

Single P-channel MOSFET

ELM14433AA-N

■ General description

ELM14433AA-N uses advanced trench technology to provide excellent $R_{ds(on)}$, low gate charge and low gate resistance. Internal ESD protection is included.

■ Features

- $V_{ds} = -30V$
- $I_d = -11A$ ($V_{gs} = -20V$)
- $R_{ds(on)} < 14m\Omega$ ($V_{gs} = -20V$)
- $R_{ds(on)} < 18m\Omega$ ($V_{gs} = -10V$)
- ESD Rating : 1500V HBM

■ Maximum absolute ratings

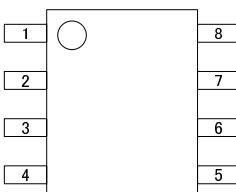
Parameter	Symbol	Limit	Unit	Note
Drain-source voltage	V_{ds}	-30	V	
Gate-source voltage	V_{gs}	± 25	V	
Continuous drain current Ta=25°C	I_d	-11.0	A	1
Ta=70°C		-9.7		
Pulsed drain current	I_{dm}	-50	A	2
Power dissipation Ta=25°C	P_d	3.0	W	1
Ta=70°C		2.1		
Junction and storage temperature range	T_j, T_{stg}	-55 to 150	°C	

■ Thermal characteristics

Parameter	Symbol	Typ.	Max.	Unit	Note
Maximum junction-to-ambient	$R_{\theta ja}$	28	40	°C/W	1
Maximum junction-to-ambient		54	75	°C/W	
Maximum junction-to-lead	$R_{\theta jl}$	21	30	°C/W	3

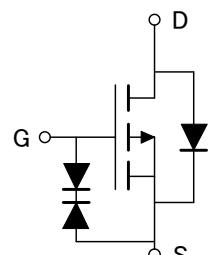
■ Pin configuration

SOP-8 (TOP VIEW)



Pin No.	Pin name
1	SOURCE
2	SOURCE
3	SOURCE
4	GATE
5	DRAIN
6	DRAIN
7	DRAIN
8	DRAIN

■ Circuit



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■ Electrical characteristics

$T_a=25^\circ C$

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
STATIC PARAMETERS						
Drain-source breakdown voltage	BVdss	$I_d=-250 \mu A, V_{gs}=0V$	-30			V
Zero gate voltage drain current	Idss	Vds=-24V			-1	μA
		$V_{gs}=0V$	$T_j=55^\circ C$		-5	
Gate-body leakage current	Igss	$V_{ds}=0V, V_{gs}=\pm 25V$			± 1	μA
Gate threshold voltage	Vgs(th)	$V_{ds}=V_{gs}, I_d=-250 \mu A$	-2.0	-2.8	-4.0	V
On state drain current	$I_d(on)$	$V_{gs}=-10V, V_{ds}=-5V$	-50			A
Static drain-source on-resistance	Rds(on)	Vgs=-20V		11.0	14.0	$m\Omega$
		$I_d=-11A$	$T_j=125^\circ C$	15.0	19.0	
		Vgs=-10V, $I_d=-10A$		13.8	18.0	$m\Omega$
		Vgs=-4.5V, $I_d=-4A$		38.5		$m\Omega$
Forward transconductance	Gfs	$V_{ds}=-5V, I_d=-11A$		20		S
Diode forward voltage	Vsd	$I_s=-1A, V_{gs}=0V$		-0.72	-1.00	V
Max. body-diode continuous current	Is				-4.2	A
DYNAMIC PARAMETERS						
Input capacitance	Ciss	$V_{gs}=0V, V_{ds}=-15V, f=1MHz$		1760	2200	pF
Output capacitance	Coss			360		pF
Reverse transfer capacitance	Crss			255		pF
Gate resistance	Rg	$V_{gs}=0V, V_{ds}=0V, f=1MHz$		6.4	8.0	Ω
SWITCHING PARAMETERS						
Total gate charge	Qg	$V_{gs}=-10V, V_{ds}=-15V$ $I_d=-11A$		30	38	nC
Gate-source charge	Qgs			7		nC
Gate-drain charge	Qgd			8		nC
Turn-on delay time	td(on)	$V_{gs}=-10V, V_{ds}=-15V$ $R_l=1.5 \Omega, R_{gen}=3 \Omega$		11.5		ns
Turn-on rise time	tr			8.0		ns
Turn-off delay time	td(off)			35.0		ns
Turn-off fall time	tf			18.5		ns
Body diode reverse recovery time	trr	$I_f=-11A, dI/dt=100A/\mu s$		24	30	ns
Body diode reverse recovery charge	Qrr	$I_f=-11A, dI/dt=100A/\mu s$		16		nC

NOTE :

1. The value of $R_{\theta ja}$ is measured with the device mounted on 1in² FR-4 board of 2oz. Copper, in still air environment with $T_a=25^\circ C$. The value in any given applications depends on the user's specific board design, The current rating is based on the $t \leq 10s$ thermal resistance rating.
2. Repetitive rating, pulse width limited by junction temperature.
3. The $R_{\theta ja}$ is the sum of the thermal impedance from junction to lead $R_{\theta jl}$ and lead to ambient.
4. The static characteristics in Figures 1 to 6 are obtained using 80 μs pulses, duty cycle 0.5%max.
5. These tests are performed with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_a=25^\circ C$. The SOA curve provides a single pulse rating.

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■ Typical electrical and thermal characteristics

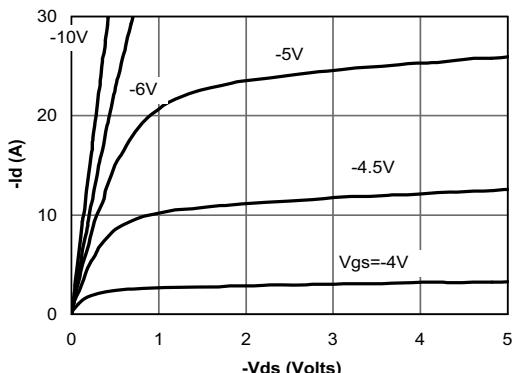


Fig 1: On-Region Characteristics

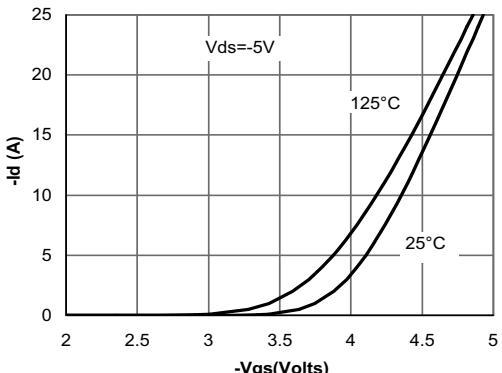


Figure 2: Transfer Characteristics

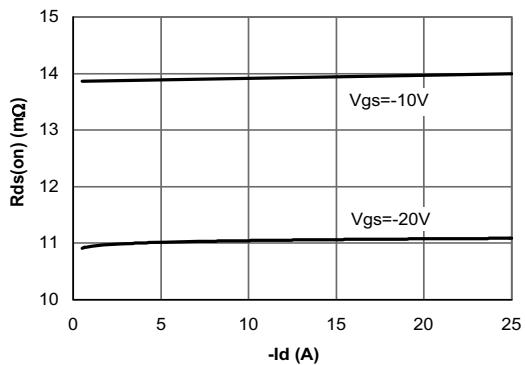


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

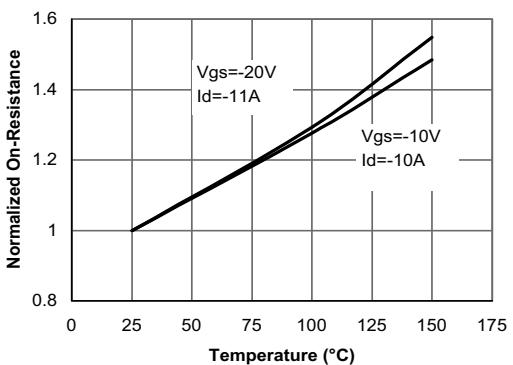


Figure 4: On-Resistance vs. Junction Temperature

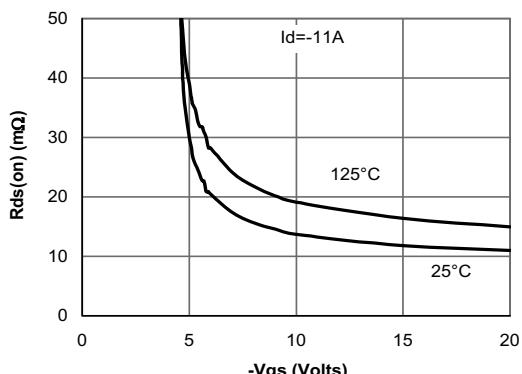


Figure 5: On-Resistance vs. Gate-Source Voltage

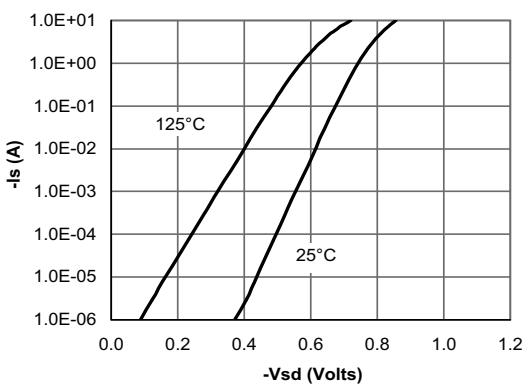


Figure 6: Body-Diode Characteristics

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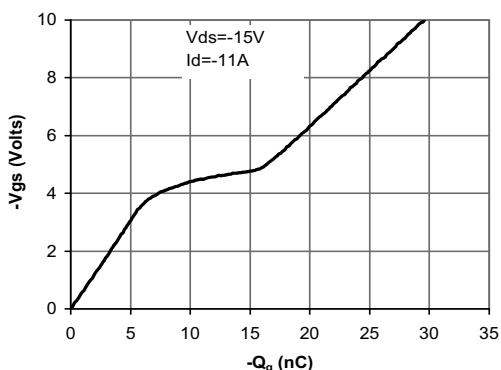


Figure 7: Gate-Charge Characteristics

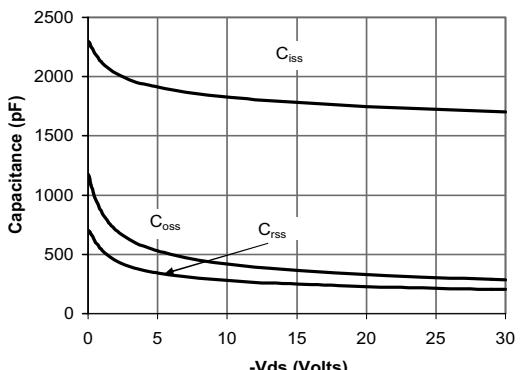


Figure 8: Capacitance Characteristics

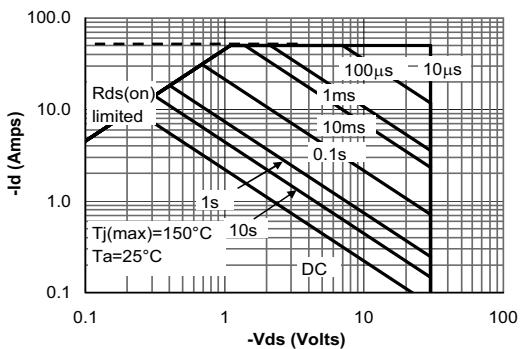


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

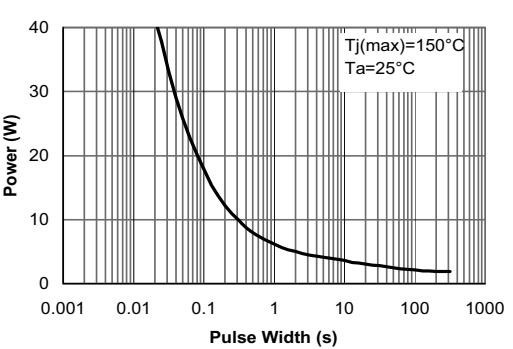


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

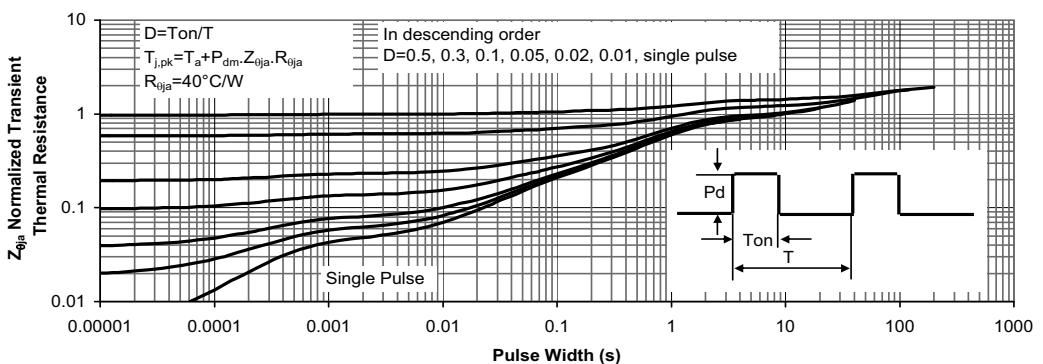


Figure 11: Normalized Maximum Transient Thermal Impedance